

High-Frequency NPN Transistor Arrays For Low-Power Applications at Frequencies Up to 1.5GHz

The CA3227 and CA3246 consist of five general purpose silicon NPN transistors on a common monolithic substrate. Each of the transistors exhibits a value of f_T in excess of 3GHz, making them useful from DC to 1.5GHz. The monolithic construction of these devices provides close electrical and thermal matching of the five transistors.

Ordering Information

PART NUMBER (BRAND)	TEMP. RANGE (°C)	PACKAGE	PKG. NO.
CA3227E	-55 to 125	16 Ld PDIP	E16.3
CA3227M (3227)	-55 to 125	16 Ld SOIC	M16.15
CA3227M96 (3227)	-55 to 125	16 Ld SOIC Tape and Reel	M16.15
CA3246M (3246)	-55 to 125	14 Ld SOIC	M14.15
CA3246M96 (3246)	-55 to 125	14 Ld SOIC Tape and Reel	M14.15

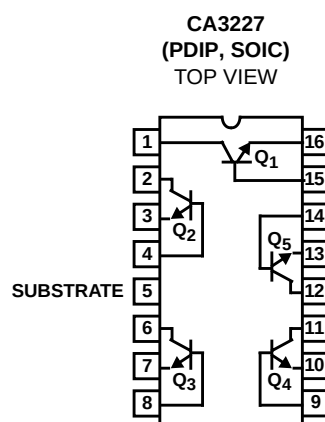
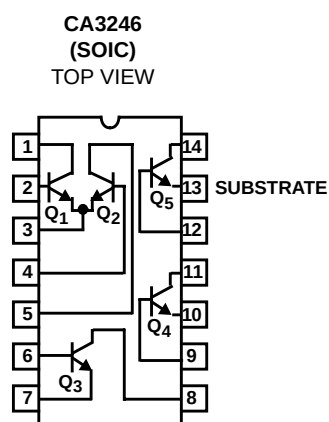
Features

- Gain-Bandwidth Product (f_T) >3GHz
- Five Transistors on a Common Substrate

Applications

- VHF Amplifiers
- VHF Mixers
- Multifunction Combinations - RF/Mixer/Oscillator
- IF Converter
- IF Amplifiers
- Sense Amplifiers
- Synthesizers
- Synchronous Detectors
- Cascade Amplifiers

Pinouts



Absolute Maximum Ratings

Collector-to-Emitter Voltage (V_{CEO})	8V
Collector-to-Base Voltage (V_{CBO})	12V
Collector-to-Substrate Voltage (V_{CIO} , Note 1)	20V
Collector Current (I_C)	20mA

Operating Conditions

Temperature Range	-55°C to 125°C
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Thermal Information

Thermal Resistance (Typical, Note 2)	θ_{JA} (°C/W)
14 Ld SOIC Package	185
16 Ld PDIP Package	90
16 Ld SOIC Package	175
Maximum Power Dissipation (Any One Transistor)	85mW
Maximum Junction Temperature (Die)	175°C
Maximum Junction Temperature (Plastic Package)	150°C
Maximum Storage Temperature Range	-65°C to 150°C
Maximum Lead Temperature (Soldering 10s)	300°C
(SOIC - Lead Tips Only)	

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

NOTES:

- The collector of each transistor of these devices is isolated from the substrate by an integral diode. The substrate (Terminal 5 (CA3227) and Terminal 13 (CA3246)) must be connected to the most negative point in the external circuit to maintain isolation between transistors and to provide for normal transistor action.
- θ_{JA} is measured with the component mounted on an evaluation PC board in free air.

Electrical Specifications $T_A = 25^\circ\text{C}$

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNITS
DC CHARACTERISTICS FOR EACH TRANSISTOR						
Collector-to-Base Breakdown Voltage	$V_{(BR)CBO}$	$I_C = 10\mu\text{A}$, $I_E = 0$	12	20	-	V
Collector-to-Emitter Breakdown Voltage	$V_{(BR)CEO}$	$I_C = 1\text{mA}$, $I_B = 0$	8	10	-	V
Collector-to-Substrate Breakdown Voltage	$V_{(BR)CIO}$	$I_{C1} = 10\mu\text{A}$, $I_B = 0$, $I_E = 0$	20	-	-	V
Emitter-Cutoff-Current (Note 3)	I_{EBO}	$V_{EB} = 4.5\text{V}$, $I_C = 0$	-	-	10	μA
Collector-Cutoff-Current	I_{CEO}	$V_{CE} = 5\text{V}$, $I_B = 0$	-	-	1	μA
Collector-Cutoff-Current	I_{CBO}	$V_{CB} = 8\text{V}$, $I_E = 0$	-	-	100	nA
DC Forward-Current Transfer Ratio	h_{FE}	$V_{CE} = 6\text{V}$, $I_C = 10\text{mA}$	-	110	-	
		$I_C = 1\text{mA}$	40	150	-	
		$I_C = 0.1\text{mA}$	-	150	-	
Base-to-Emitter Voltage	V_{BE}	$V_{CE} = 6\text{V}$, $I_C = 1\text{mA}$	0.62	0.71	0.82	V
Collector-to-Emitter Saturation Voltage	$V_{CE SAT}$	$I_C = 10\text{mA}$, $I_B = 1\text{mA}$	-	0.13	0.50	V
Base-to-Emitter Saturation Voltage	$V_{BE SAT}$	$I_C = 10\text{mA}$, $I_B = 1\text{mA}$	0.74	-	0.94	V

NOTES:

- On small-geometry, high-frequency transistors, it is very good practice never to take the Emitter Base Junction into reverse breakdown. To do so may permanently degrade the h_{FE} . Hence, the use of I_{EBO} rather than $V_{(BR)EBO}$. These devices are also susceptible to damage by electrostatic discharge and transients in the circuits in which they are used. Moreover, CMOS handling procedures should be employed.

Electrical Specifications $T_A = 25^{\circ}\text{C}$, 200MHz, Common Emitter, Typical Values Intended Only for Design Guidance

PARAMETER	SYMBOL		TEST CONDITION	TYPICAL VALUES	UNITS
DYNAMIC CHARACTERISTICS FOR EACH TRANSISTOR					
Input Admittance	Y ₁₁	b ₁₁	I _C = 1mA, V _{CE} = 5V	4	mS
		g ₁₁		0.75	mS
Output Admittance	Y ₂₂	b ₂₂	I _C = 1mA, V _{CE} = 5V	2.7	mS
		g ₂₂		0.13	mS
Forward Transfer Admittance	Y ₂₁	Y ₂₁	I _C = 1mA, V _{CE} = 5V	29.3	mS
		θ ₂₁		-33	Degrees
Reverse Transfer Admittance	Y ₁₂	Y ₁₂	I _C = 1mA, V _{CE} = 5V	0.38	mS
		θ ₁₂		-97	Degrees
Input Admittance	Y ₁₁	b ₁₁	I _C = 10mA, V _{CE} = 5V	4.8	mS
		g ₁₁		2.85	mS
Output Admittance	Y ₂₂	b ₂₂	I _C = 10mA, V _{CE} = 5V	2.75	mS
		g ₂₂		0.9	mS
Forward Transfer Admittance	Y ₂₁	Y ₂₁	I _C = 10mA, V _{CE} = 5V	95	mS
		θ ₂₁		-62	Degrees
Reverse Transfer Admittance	Y ₁₂	Y ₁₂	I _C = 10mA, V _{CE} = 5V	0.39	mS
		θ ₁₂		-97	Degrees
Small Signal Forward Current Transfer Ratio	h ₂₁		I _C = 1mA, V _{CE} = 5V	7.1	
			I _C = 10mA, V _{CE} = 5V	17	
TYPICAL CAPACITANCE AT 1MHz, THREE-TERMINAL MEASUREMENT					
Collector-to-Base Capacitance	C _{CB}		V _{CB} = 6V	0.3	pF
Collector-to-Substrate Capacitance	C _{CI}		V _{CI} = 6V	1.6	pF
Collector-to-Emitter Capacitance	C _{CCE}		V _{CE} = 6V	0.4	pF
Emitter-to-Base Capacitance	C _{EB}		V _{EB} = 3V	0.75	pF

Spice Model (Spice 2G.6)

.model NPN

+	BF = 2.610E + 02	BR = 4.401E + 00	IS = 6.930E - 16	RB = 130.0E + 00
+	RC = 1.000E + 01	RE = 7.396E - 01	VA = 6.300E + 01	VB = 2.208E + 00
+	IK = 1.000E - 01	ISE = 1.87E - 14	NE = 1.653E + 00	IKR = 1.000E - 02
+	ISC = 9.25E - 14	NC = 1.333E + 00	TF = 1.775E - 11	TR = 1.000E - 09
+	CJS = 1.800E - 12	CJE = 1.010E - 12	PE = 8.350E - 01	ME = 4.460E - 01
+	CJC = 9.100E - 13	PC = 3.850E - 01	MC = 2.740E - 01	KF = 0.000E + 00
+	AF = 1.000E + 00	EF = 1.000E + 00	FC = 5.000E - 01	PJS = 5.410E - 01
+	MJS = 3.530E - 01	RBM = 30.00	RBV = 100	IRB = 0.00

Please Note: No measurements have been made to model the reverse AC operation (tr is an estimation).

Typical Performance Curves

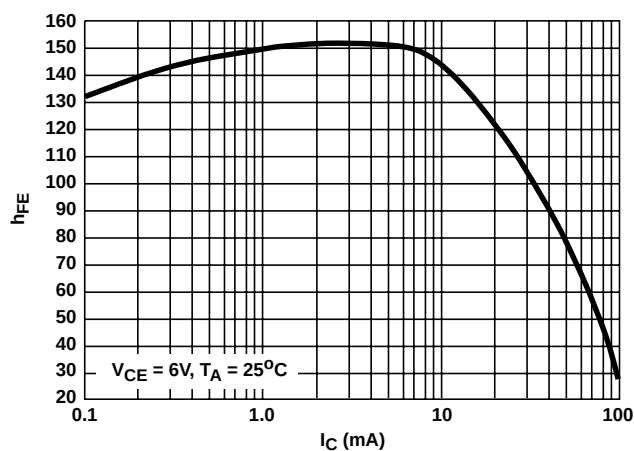
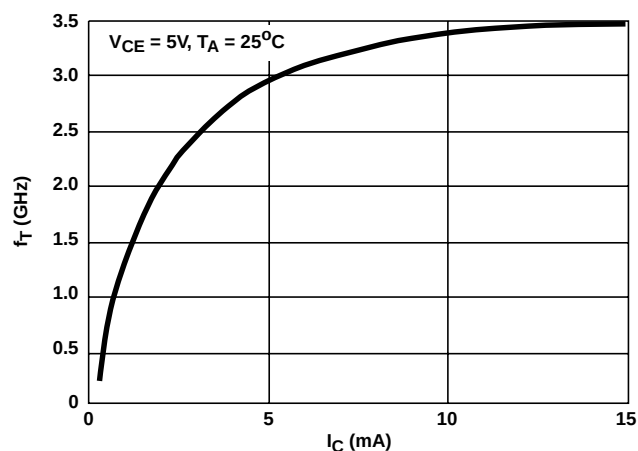
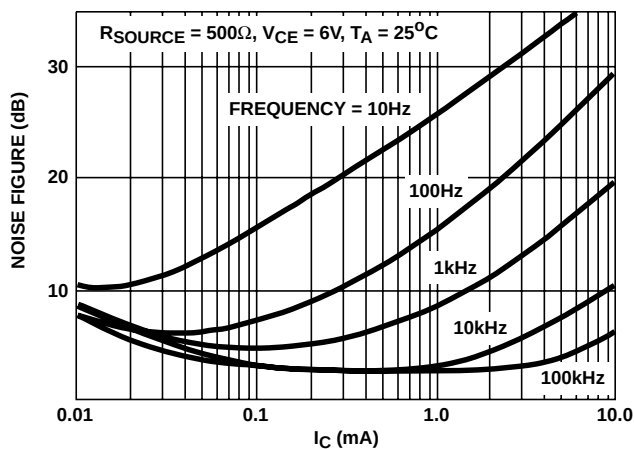
FIGURE 1. h_{FE} vs COLLECTOR CURRENTFIGURE 2. f_T vs COLLECTOR CURRENT

FIGURE 3. NOISE FIGURE vs COLLECTOR CURRENT

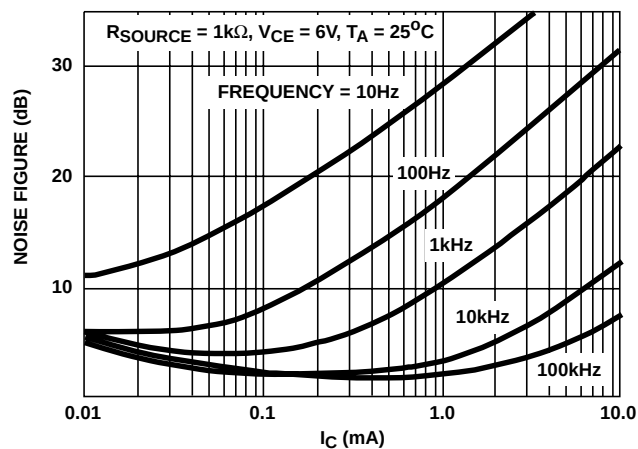


FIGURE 4. NOISE FIGURE vs COLLECTOR CURRENT

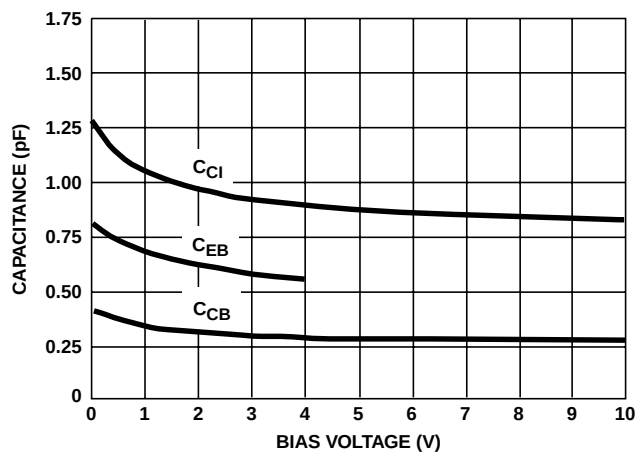


FIGURE 5. CAPACITANCE vs BIAS VOLTAGE

Die Characteristics

DIE DIMENSIONS:

46 mils x 32 mils - CA3227

47 mils x 33 mils - CA3246

Metallization Mask Layout

